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Author Correction: Orientational Mapping Augmented Sub-Wavelength Hyper-Spectral Imaging of Silk

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In this Article, Junko Morikawa is incorrectly listed as being affiliated with 'Infrared Microspectroscopy Beamline, Australian Synchrotron, Clayton, Victoria, 3168, Australia'

The correct affiliation is listed below:

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This error has now been corrected in the PDF and HTML versions of the paper, and in the accompanying Supplementary Information.

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